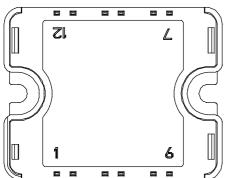


### **Boost chopper NPT IGBT Power Module**

## $I_{C} = 90A$ (*a*) $Tc = 80^{\circ}C$

#### 5 6 11 $\bigcirc$ CR1 3 X NTC Q2 CR2 9 10 (12 1 2



Pins 1/2; 3/4; 5/6 must be shorted together

#### Absolute maximum ratings

#### Symbol Parameter Max ratings Unit Collector - Emitter Breakdown Voltage 600 V V<sub>CES</sub> $T_c = 25^{\circ}C$ 110 $I_C$ Continuous Collector Current $T_c = 80^{\circ}C$ 90 Α Pulsed Collector Current $T_c = 25^{\circ}C$ I<sub>CM</sub> 315 V<sub>GE</sub> Gate – Emitter Voltage $\pm 20$ V $T_c = 25^{\circ}C$ $P_{D}$ Maximum Power Dissipation 416 W $T_i = 150^{\circ}C$ RBSOA Reverse Bias Safe Operating Area 200A @ 600V

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

# $V_{CES} = 600V$

#### Application

- AC and DC motor control .
- Switched Mode Power Supplies
- Power Factor Correction

#### Features

- Non Punch Through (NPT) Fast IGBT •
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS** Compliant

www.microsemi.com

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#### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_i = 25^{\circ}C$			250	μA
		$V_{CE} = 600V$	$T_{i} = 125^{\circ}C$			500	μΛ
V <sub>CE(sat)</sub>	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V
		$I_C = 90A$	$T_j = 125^{\circ}C$		2.2		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1 \text{ mA}$		3		5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20 V, V_{CE} = 0V$				±150	nA

#### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$			4300		
C <sub>oes</sub>	Output Capacitance				470		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz		400			
Qg	Total gate Charge	$V_{GE} = 15V$		330		nC	
Q <sub>ge</sub>	Gate – Emitter Charge	$V_{Bus} = 300V$			290		
Qgc	Gate – Collector Charge	$I_C = 90A$		200			
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switch		26		ns	
T <sub>r</sub>	Rise Time	$V_{GE} = 15V$		25			
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_C = 90A$		150			
T <sub>f</sub>	Fall Time	$R_G = 5 \Omega$		30			
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switch	ing (125°C)		26		
Tr	Rise Time	$V_{GE} = 15V$			25		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_C = 90A$ $R_G = 5 \Omega$			170		ns
$T_{\rm f}$	Fall Time				40		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$	$T_j = 125^{\circ}C$		4.3		
E <sub>off</sub>	Turn-off Switching Energy	$I_{C} = 90A$ $R_{G} = 5 \Omega$	$T_j = 125^{\circ}C$		3.5		mJ

#### Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
T	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_j = 25^{\circ}C$			100	μA
I <sub>RM</sub>			$T_{j} = 125^{\circ}C$			500	μΑ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		100		А
	Diode Forward Voltage	$I_F = 100A$			1.6	2	
V <sub>F</sub>		$I_{\rm F} = 200 {\rm A}$		2		V	
		$I_{\rm F} = 100 {\rm A}$	$T_j = 125^{\circ}C$		1.3		
t	Reverse Recovery Time		$T_j = 25^{\circ}C$		160		ns
t <sub>rr</sub>		$I_{\rm F} = 100 \text{A}$ $V_{\rm R} = 400 \text{V}$	$T_j = 125^{\circ}C$		220		115
Q <sub>rr</sub>	Reverse Recovery Charge	$v_R = 400 v$ di/dt = 200 A/µs	$T_j = 25^{\circ}C$		290		nC
		•	$T_j = 125^{\circ}C$		1530		ne



#### Thermal and package characteristics

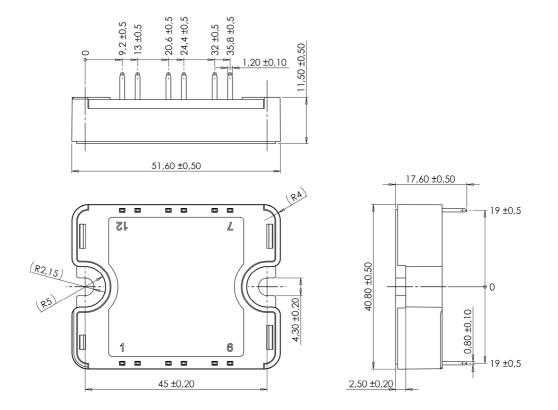
Symbol	Characteristic			Min	Тур	Max	Unit	
P	Lunction to Case Thermal Resistance		IGB	Г			0.3	°C/W
R <sub>thJC</sub>			Diod	le			0.55	C/ W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V	
T <sub>J</sub>	Operating junction temperature range			-40		150		
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C	
T <sub>C</sub>	Operating Case Temperature						100	
Torque	Mounting torque	To heatsink		M4	2		3	N.m
Wt	Package Weight						80	g

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

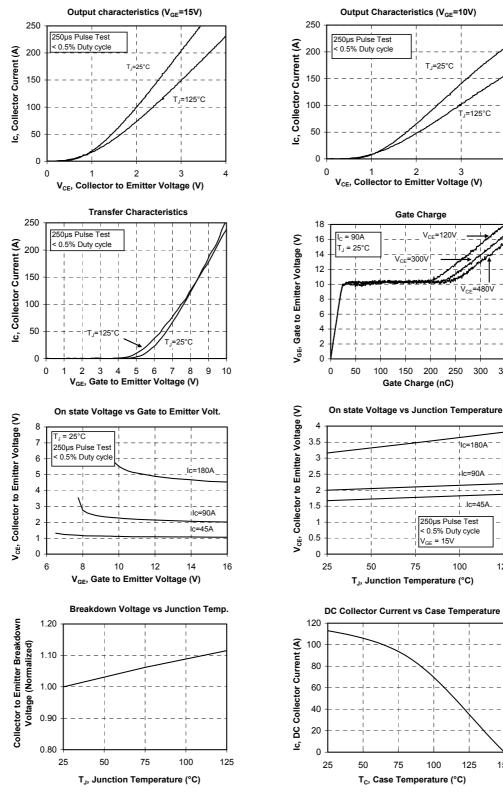
#### SP1 Package outline (dimensions in mm)



See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com



#### **Typical Performance Curve**



### APTGF90DA60T1G

=125°C

480

300 350

125

150

4



25

50

Turn-On Delay Time vs Collector Current (i) 35  $V_{GE} = 15V$   $V_{GE} = 15V$   $V_{GE} = 15V$   $V_{GE} = 15V$   $V_{GE} = 400V$  $R_{G} = 5\Omega$ 

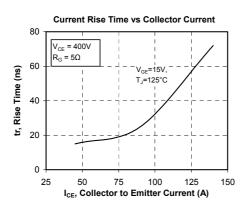
I<sub>CE</sub>, Collector to Emitter Current (A)

100

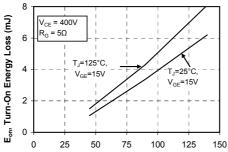
125

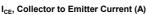
150

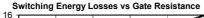
75

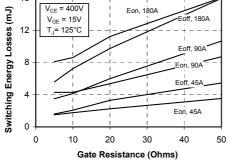


Turn-On Energy Loss vs Collector Current

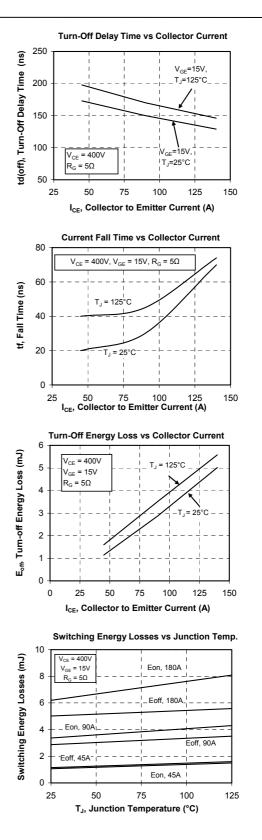




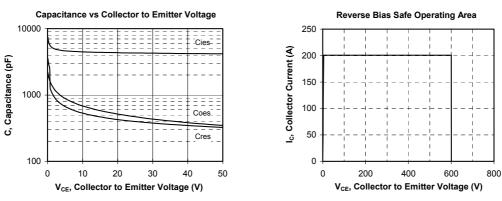


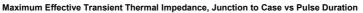


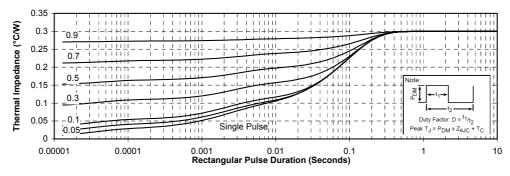
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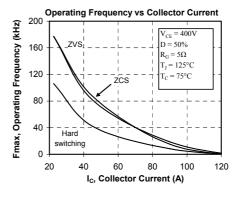














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